

**Search Notes**

Application/Control No.

10/628,453

Examiner

Simon J. Oh

Applicant(s)/Patent under  
Reexamination

MUSA ET AL.

Art Unit

1618

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR